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Investigation on the effect of impurities in xenon based dielectric barrier discharge lamps

A N Dagang^{1,2}, S Bhosle^{1,3}, G Zisis^{1,2} and A Corazza⁴

¹Université de Toulouse, UPS, INPT, LAPLACE (Laboratoire Plasma et Conversion d'Energie), 118 route de Narbonne, F-31062 Toulouse Cedex 9, France

²CNRS LAPLACE, F-31062 Toulouse, France

³LED Engineering Development, 11 rue du Mont Dore, F-31100 Toulouse, France

⁴SAES Getters S.p.A, Viale Italia, 20020 Lainate, Milan, Italy

E-mail: ahmad.dagang@laplace.univ-tlse.fr

Abstract. In any discharges, the existence of impurities could give a severe change or bring a negative or positive effect to the discharge and plasma characteristics. The authors purposely added a few kinds of impurities and their effect on the discharge was investigated. The common and typical impurities of H₂, N₂, CO₂ and CH₄ were applied in varying concentration percentages into a xenon DBD lamp. Their discharge condition, emission spectra and electrical characteristics were studied. The plasma generation differs from one type of impurity to another. With two different concentrations of hydrogen, at 5% concentration it would stabilize the discharge and at 0.5% concentrations it would give an additional collision process where a strong peak of atomic lines were observed. Nitrogen with two types of concentration i.e., 1% and 0.1% gives two kinds of characteristics in emission spectroscopy. From the electrical parameters, the voltage across the gap shows the lamps with impurities have a higher value compared to the pure xenon lamp.

1. Introduction

In dealing with vacuum sealing tubes the problems relating to impurities sometimes cannot be avoided. The main impurities are typically from hydrogen (H_2), nitrogen (N_2), carbon monoxide (CO), carbon dioxide (CO_2), methane (CH_4), etc. The impurities can come out from the pumping system or from water vapor. It has been recognized that a small amount of water vapor will catalyze the dissociation of O_2 in electrical discharges, and N_2 , NO, N_2O and H_2 were also found to have this catalytic effect[1, 2]. They also can be out gassed from the discharge tube itself when quartz or fused silica tubes are used, and where they may contain relatively high quantities of hydroxyl radical (OH^-) that can be dissociated into O and H[3]. Particularly in lamps, the presence of hydrogen even in a few parts per million (PPM) in the tube can cause an increase in starting voltage and ignition problems especially in high intensity discharge (HID) lamps[4].

Xenon based discharge has been identified as an alternative candidate to mercury, and as such the authors have used xenon based discharge in an effort to develop mercury-free lamps. Xenon is non-toxic gas and is chemically stable compared to mercury. In low pressure discharge xenon emits strong resonance and excimer emissions in vacuum ultra violet (VUV) regions that can be converted with good efficiency in UV to visible light through phosphor. Xenon low pressure lamps such as exciplex lamp (xenon with halogens) was developed to be used for sterilization and medical treatment[5]. In high pressure discharge it is able to emit strong continuum emissions in visible regions[6], where xenon high pressure arc discharge lamp has been used such as in spectrophotometer. Xenon arc lamp also has a good color rendering with extremely high luminance, for example Osram XBO lamp which has been used for cinema film projection, light guide system, etc. Xenon based discharge also has an advantage in temperature-independence, capable of instant starting and restarting compared to mercury lamps as there is no evaporation process required. Many efforts have been undertaken by a number of researchers using DC, AC or pulse, with conventional type discharge (with electrode), with electrodeless type discharge such as dielectric barrier discharge (DBD), inductively coupled plasma (ICP) and microwave discharge, and their performance has been improving[7-13].

In order to avoid any contamination from the internal electrodes, an electrodeless discharge DBD was applied. DBD is one type of capacitive coupled plasma which has been used mainly in developing excimer lamps and is also one of the most common types of industrial plasma sources. It is the simplest type of electrodeless discharge, essentially consisting of two electrodes separated by a small distance of dielectric material. The authors applied DBD to a small-gap discharge tube to make it easy to obtain a single filament discharge. This is important in order to obtain an intense filament-like discharge due to the difficulties in getting better emission spectra from the low intensity of glow-like discharge.

As an initial step towards the aim of developing mercury-free light sources, xenon low pressure with the purposely inserted impurities lamps are used. In this paper, the

studies are focused on the effect of impurities on xenon DBD lamp, and the possibility of the mix gases (impurities with xenon) to be applied as a light source. The effects of typical type of impurities i.e. H_2 , N_2 , CO_2 and CH_4 are evaluated, and applied using pulsed AC high voltage. Their discharge condition, spectroscopic and electrical characteristics are investigated.

2. Experimental setup

2.1. Lamps and plasma generation

The schematic diagram and experimental setup are shown in figures 1 and 2. The lamps (discharge tubes) used are a cube type quartz tube (12×12 mm) with a glass thickness of 1 mm as described in figure 1. The lamp was ignited using a DBD source. The DBD is supplied with pulse voltage with the amplitude ranging from 5 to 6 kV, at a pulse width of $1 \mu s$, and the frequency is changed from 70 to 150 kHz. In some cases, in order to ignite the plasma an auxiliary excitation is needed. In this case a pen type Hg-Ar lamp is used as an ignitor by lighting it near to the lamp then removing when the plasma is produced. The compositions of each lamp are shown in table 1.

2.2. Spectroscopic measurement

Emission spectra were measured using Ocean Optics HR4000, a high resolution miniature fibre optic spectrometer. This spectrometer can provide an optical resolution at 0.025 nm and is responsive from 200 to 1100 nm. Fibre used is $400 \mu m$ in diameter, a UV-VIS High OC content type with its most efficient wavelength at 300 to 800 nm. The setup is shown in figure 1 composed with fiber, spectrometer and personal computer. Since the plasma intensity is different from one lamp to another, the integration time of the spectrometer was changed accordingly from 200 to 2000 ms (longer time for less intense plasma). The spectroscopic sensitivity was calibrated using a Mikropack GmbH DT-Mini-2-GS deuterium halogen standard light source.

2.3. Electrical parameters measurement

For every discharge, the applied voltage and current were measured. They were measured using a Pintek Electronics high voltage probe HVP20AC/30DC (5 MHz) and a Tektronix P6021 10 mA/mV (120 kHz~60 MHz) current probe for voltage and current measurements respectively. A Tektronix P2220 1x/10x (200 MHz) voltage probe was used to measure the displaced charge across the lamp. The waveforms were recorded using a digital oscilloscope Tektronix TDS 2024 (200MHz).

Technique to determine the electrical parameters in DBD

Based on measured $V-I$ (voltage and current) and $V-Q$ (Lissajous diagram) results, the internal electric parameters such as voltage across the dielectric, voltage across the gap,

discharge current, excitation power and energy inputted into plasma can be calculated. The equivalent circuit and DBD electrode configuration is shown in figure 2. The main equations are shown below[5].

$$\text{Gas gap voltage : } U_g(t) = U(t) - U_{\text{die}}(t) \quad (1)$$

$$\text{Dielectric voltage : } U_{\text{die}}(t) = \frac{Q(t)}{C_{\text{die}}} \quad (2)$$

$$\text{Total charge : } Q(t) = U_{\text{add}}(t)C_{\text{add}} \quad (3)$$

$$\text{Gas capacitance : } C_g = \frac{C_{\text{lamp}}C_{\text{die}}}{C_{\text{die}} - C_{\text{lamp}}} \quad (4)$$

$$\text{Discharge current : } I_d(t) = I(t) - C_g \frac{\partial U_g}{\partial t} \quad (5)$$

$$\text{Excitation power : } P(t) = U_g(t)I_d(t) \quad (6)$$

$$\text{Inputted energy : } E(t) = \int_0^t P(t')dt' \quad (7)$$

Measured voltage and current are described as $U(t)$ and $I(t)$ respectively. $Q(t)$ can be calculated by measuring voltage drop U_{add} across an additional capacitor C_{add} that connected in series to the lamp as shown in figure 2. The value of C_{add} is determined based on the basis of $Z_{\text{add}} \ll Z_{\text{lamp}}$, here the authors used $C_{\text{add}}=100$ pF. Dielectric capacitance C_{die} is simplified to one capacitance and its value together with lamp capacitance C_{lamp} value can be obtained from the slope of the corresponding segments of V - Q characteristics[13].

3. Results

3.1. Plasma condition

Discharge images for each lamp are shown in figure 3 for frequencies 80, 100, 120 and 140 kHz. For each discharge there are differences in plasma intensity and stability. As can be seen in figure 3, lamps 1 and 5 produced a thick filament-like discharge compared to the rest of the lamps. This shows these two lamps have relatively high intensity and are more stable. For lamps 3, 4 and 6, the discharge was getting unstable (filament kept moving) when the frequency is increased. The most stable plasma produced was from lamp 2, where the position of a filament remained unchanged when the frequency was adjusted. Instead, its filament becomes diffuse when frequency is increased. Lamp 2 is a lamp with a high concentration of H_2 , and this condition can be considered one of the reasons for obtaining stable plasma compared with lamp 3 with low concentration of H_2 which was unstable. Lamp 7 with high concentration of CH_4 is the most difficult to ignite the plasma, the intensity is the lowest among the lamps but the discharge was stable.

3.2. Emission spectra

Emission spectra for the lamp with pure xenon and the lamps with each impurity (H_2 , N_2 , CO_2 , CH_4) at the frequencies of 80, 100, 120 kHz are shown in figures 4, 5 and 6 respectively. A discussion here will focus on near UV and visible regions as shown in the figures with wavelength of 300~800 nm, the most efficient range of spectrometer and fiber. As can be seen in figures 4~6, when the frequency is increased emission spectra intensities decreases, while emitted spectra and waveforms remain unchanged. For these four types of impurities, the molecular spectra only can be observed in the lamp with nitrogen at 1% concentration (lamp 4) where typical 2nd positive band of N_2 molecular spectra can be seen at 300~400 nm. However for the lamp with nitrogen at 0.1% concentration (lamp 5), there are no particular atomic or molecular lines that can be observed except xenon atomic 764.20 nm and in this case the waveform is similar to lamp 1, where a weak continuum emission can be seen at 350~450 nm and 500~550 nm. For the other lamps, most of the lines that can be seen are from xenon atomic spectra. The lines are mainly assigned to xenon atomic lines of 450.10, 467.12, 473.41, 491.65 nm that belong to transitions originating from $5p^56p$ ($2p_1$ to $2p_{10}$) configuration at energy levels between 9.58 eV and 11.98 eV. In the case of 0.5% hydrogen contained lamp (lamp 3), the typical hydrogen atomic lines of 656.28 nm, 486.13 nm and 434.05 nm (for hydrogen α , β , γ) cannot be observed. Xenon atomic lines of 467.12 nm, 688.21 nm, 711.96 nm and 764.20 nm are strongly observed. The same observation goes to the 5% hydrogen contained lamp (lamp 5) but the atomic lines are weaker. In case of lamps with CO_2 and CH_4 (lamps 6 and 7), these have relatively low intensity and it is difficult to identify the spectra lines due to the noise that was simultaneously observed. However, as in previous cases, xenon atomic lines of 476.12 nm and 764.20 nm can be clearly identified.

3.3. Electrical characteristics

Figure 7 shows an example of the measured waveforms of applied voltage, total current and a Lissajous diagram (V - Q) of displaced charge. Dielectric capacitance C_{die} and lamp capacitance C_{lamp} were defined using corresponding slopes of a Lissajous diagram. Based on these results, gas gap voltage V_g , discharge current I_d , excitation power P and inputted energy E were calculated and shown in figure 8 for lamp 1 as an example. Detailed values of each peak for every lamp at 80, 100 and 120 kHz are shown in table 2. As can be seen from the table, when the frequency is increased the values of gas gap voltage, discharge current and excitation power decreases, while the inputted energy shows uncertain tendency. The gas gap voltage of lamps with impurities is higher (except lamp 2 at higher frequency) than pure xenon lamp (lamp 1). At all frequencies, the gas gap voltage for lamps with higher hydrogen concentration lamp and pure xenon lamp (lamps 1 and 2) are the lowest and is approximately 0.5 to 1.5 kV lower than other lamps. In the case of discharge current and excitation power, the nitrogen concentration lamps (lamps 4 and 5) are the lowest and the lamp with lower hydrogen concentration (lamp 3) is highest among the lamps. The excitation power for lamps with hydrogen and

carbon elements (lamps 3, 6, 7) are much higher than rest of the lamps. The inputted energy for the xenon lamp (lamp 1), is higher compared to the lamps with impurities (except lamp 4) at 100 kHz but lower at 120 kHz.

4. Discussion

4.1. Effect of hydrogen (H_2)

Hydrogen has been used because of it is the most common impurity in the vacuum tube. Two different concentrations of H_2 (0.5% and 5%) have been used. From these two conditions, a big difference in terms of discharge stability is observed. With a high concentration of H_2 (5% of H_2 , lamp 2), plasma that is produced being more stable meaning there is no unconditional movement compared to the low concentration (0.5% of H_2 , lamp 3) where plasma moves timely even without any change in the supplied power. As can be seen from the discharge images in figure 3, discharge at lamp 2 is more diffused which is something that favors the use of phosphor, whereas discharge at lamp 3 is more constricted. Electrical parameters as in table 2 for these two lamps show that the discharge current for lamp 2 is much lower compared to the lamp 3 at all frequencies. In xenon discharge, one of the characteristics is that it tends to constrict at high current density, and the result shows this tendency. In other words, it shows that H_2 can work as a discharge stabilizer which can avoid an unstable filamentary state at high percentages of concentration. In development of xenon fluorescent lamp, in order to obtain large luminous flux, a diffuse glow discharge with higher xenon pressure or large input current or power is required[8]. Because of the characteristics of xenon discharge as mentioned above it is difficult to realize. From the authors results, there is a possibility of diffuse xenon-hydrogen discharge at higher current density that could be obtained by adding some small percentage of hydrogen (percentage need to be optimized).

In terms of emission spectra, as can be seen in figures 4 and 5 only from H_2 concentration lamps a strong peak of xenon atomic lines can be observed. For example the red xenon atomic lines of 618.24 nm and 631.81 nm at energy level between 9.68 eV and 11.68 eV which cannot be observed in other lamps included the xenon reference lamp. Furthermore, a weak continuum emission also can be seen at 450~700 nm. From these results of strong atomic lines and continuum emission, the presence of H_2 in a small amount causes additional collision processes, could change the electron power balance which bring larger power losses in collision and consequently resulted more excitation, ionization and electron-ion recombination processes. The more excitation, ionization and recombination processes occur, the more excitation power will be needed. This is supported by the results from the electrical parameters where for the lamps containing a hydrogen element, where their excitation power is higher compared to other lamps. The increase of excitation process (strong atomic lines and continuum emission) especially in lamp 3 also could be due to autoionising states of xenon produced in negative hydrogen ions (H^-)[14, 15]. Curran *et al.*[15] reported that the mixture of hydrogen-xenon gases

causes a very large increase in the electron density.

4.2. Effect of nitrogen (N_2)

Nitrogen was used in order to see the effect of its 2nd positive band lying around 350 nm, and also to obtain an excitation by low energy electrons. Xenon discharge does not have an inelastic collision cross section below 8.3 eV. However, nitrogen has an excitation probability at 1.4~4 eV, the process which is due to the vibrational heating[16]. N_2 in low concentration (0.1%, lamp 5) produced a more intense and stable plasma compared to the higher one (1%, lamp 4). This condition is vice-versa with the H_2 concentration lamp in terms of discharge stability. However it is less stable than the H_2 concentration lamp where in the case of N_2 when the frequency is increased it tends to move. However at a low N_2 concentration, with a thick filament the intensity is high but this tendency is not of a much benefit in developing xenon fluorescent lamps. This is because a strong filamentary discharge could minimize phosphor excitation. There are no strong atomic lines that can be observed from the emission spectra. The waveform is similar with a xenon lamp but the continuum emissions at 350~450 nm and 500~550 nm that can be seen strongly in the xenon lamp are significantly weaker. In the case of higher concentrations, molecular spectra can be observed at near UV with the continuum emissions at 620~700 nm and 720~780 nm. The near UV lines would be appropriate for phosphor excitation with less Stokes losses. The continuum emissions at wavelengths in the red color region may not be so helpful in obtaining a white color light source, but they could be used to give a balance in color rendering if the blue and green spectrum can be produced using phosphor excitation.

In terms of electrical parameters, its discharge current and excitation power are the lowest among the lamps. This could be due to the low excitation energy of nitrogen molecule. As mentioned above, vibrational-excited nitrogen molecules need only around 4 eV to be excited and this low energy electron could help to produce the excited nitrogen molecules and consequently generate excited xenon atoms[16].

4.3. Effect of carbon (CO_2 and CH_4)

The lamps with carbon elements (CO_2 and CH_4 concentration lamps) were the most difficult among the used lamps in terms of plasma ignition which is needed to give a longer time of auxiliary excitation. The discharge of the CO_2 concentration lamp is not stable with all values of frequency. For the CH_4 concentration lamp, the discharge is stable but its intensity is significantly low, the lowest among the lamps. The unstable filamentary discharge and an extremely low intensity make it the integration time of spectrometer needed to be increased. As a result, emission spectra obtained from the lamps were accumulated with noises. The initial target of this kind of concentration (with the carbon element) was to obtain the C_2 swan bands molecular spectra which is believed to produce a white light and an intense plasma. This is because the swan system bands $A^3 \Pi_g - X'^3 \Pi_u$ [17], have a broad molecular spectra in visible regions lying

on wavelength of 430~660 nm with several main heads. Kado *et al.*[18] reported the possibility of producing C₂ molecules from methane DBD, however, with the authors current setup, it could be there is not enough energy to dissociate the molecules. It was not only C₂, the other spectra from molecular dissociation such as H₂, O₂, CO and OH radical also cannot be identified. From the electrical parameter results, the gas gap voltage and the power excitation of these lamps can be considered high enough (compared to the results of the excimer lamp in reference 5) to dissociate the molecules and it could be that the method of spectroscopy measurement needs to be changed. The next approach that could be considered is to increase the applied voltage and at the same time improve the method of spectroscopy measurement.

5. Conclusion

The basic investigations on the effects of typical impurities have been done. The use of H₂ at 5% of concentration could help to diffuse and stabilize the plasma and at another concentration of 0.5% it could increase the excitation, ionization and recombination processes. N₂ with a low concentration lamp does not fulfil the target to see a strong emission at near UV but with a high concentration lamp a significant emission spectra can be observed. With two different characteristics obtained from emission spectra, the other results with different concentration are preferable. In the case of CO₂ and CH₄ concentration lamps, typical molecular spectra cannot be observed. Together with the H₂ concentration lamps, a high excitation power is obtained from their discharge. As such it is believed that by changing the method or setup of spectroscopy measurement, a molecular spectrum could be observed. This will be the next step of the research and the work is ongoing.

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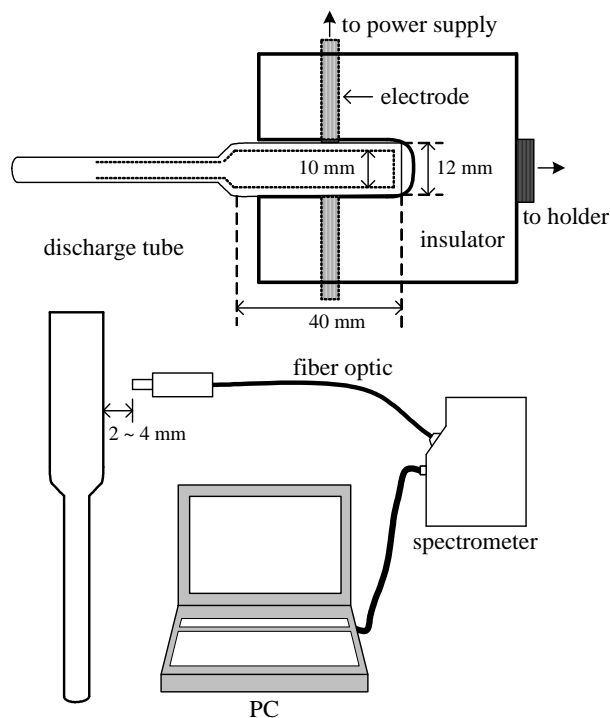


Figure 1. Experimental setup with a tube dimension diagram.

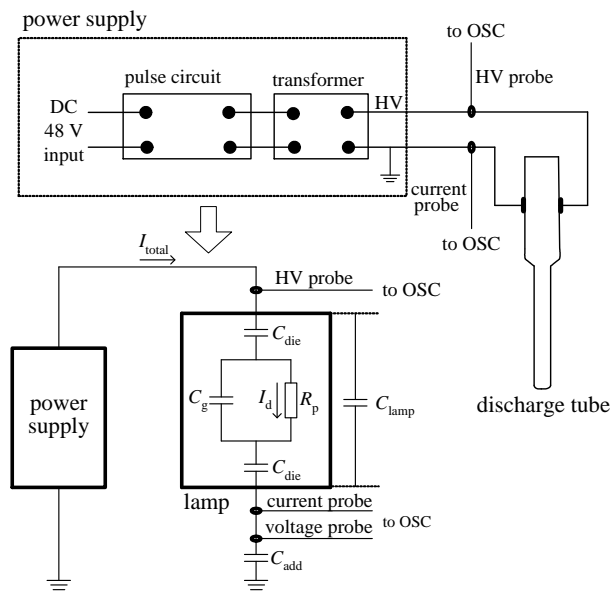
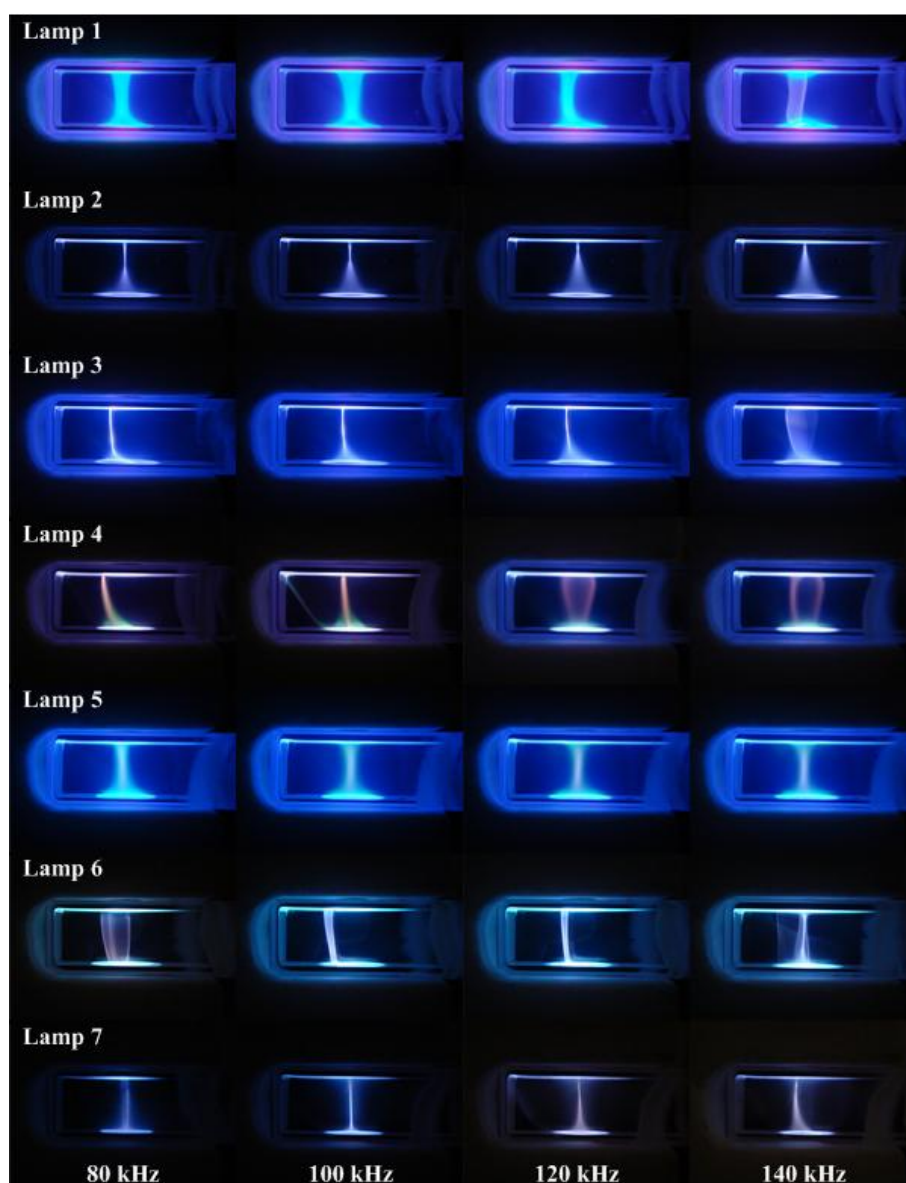


Figure 2. A schematic diagram of the power supply and an equivalent circuit of DBD. Gas capacitance C_g , dielectric capacitance C_{die} , additional capacitance C_{add} , discharge current I_d and plasma resistance R_p .

Table 1. Lamps number and their corresponding compositions. All lamps are with a total pressure of 150 Torr.

Lamp No.	Gas composition
1	Xe
2	Xe-H ₂ (95%-5%)
3	Xe-H ₂ (99.5%-0.5%)
4	Xe-N ₂ (99%-1%)
5	Xe-N ₂ (99.9%-0.1%)
6	Xe-CO ₂ (99.5%-0.5%)
7	Xe-CH ₄ (95%-5%)

**Figure 3.** Discharge images for lamps 1~7 at frequency of 80, 100, 120 and 140 kHz.

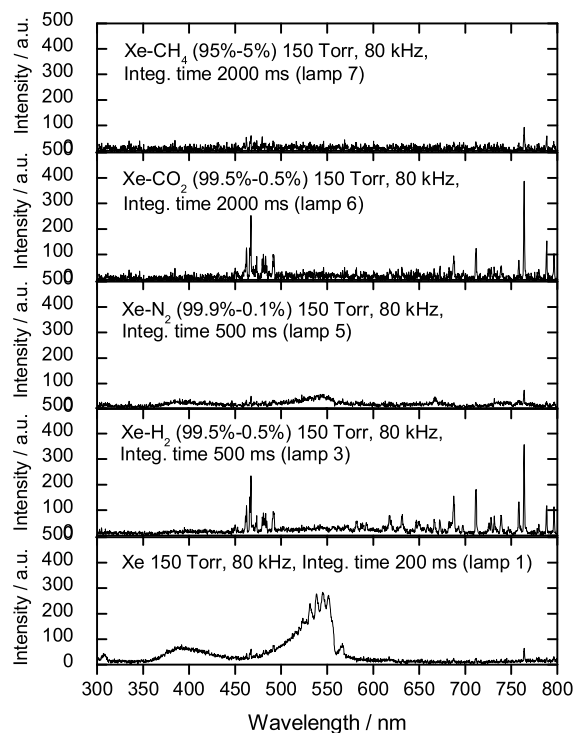


Figure 4. Emission spectra of the lamps with xenon reference lamp and impurities concentration lamps (lamps 3,5,6,7) at frequency 80 kHz.

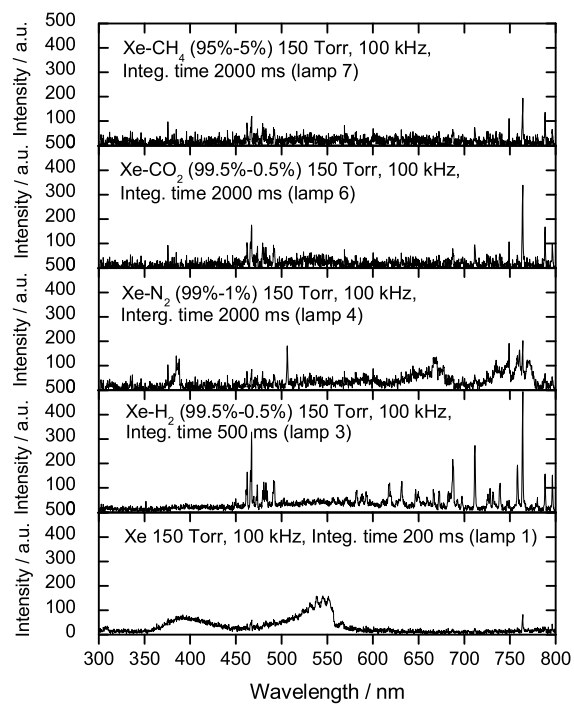


Figure 5. Emission spectra of the lamps with xenon reference lamp and impurities concentration lamps (lamps 3,4,6,7) at frequency 100 kHz.

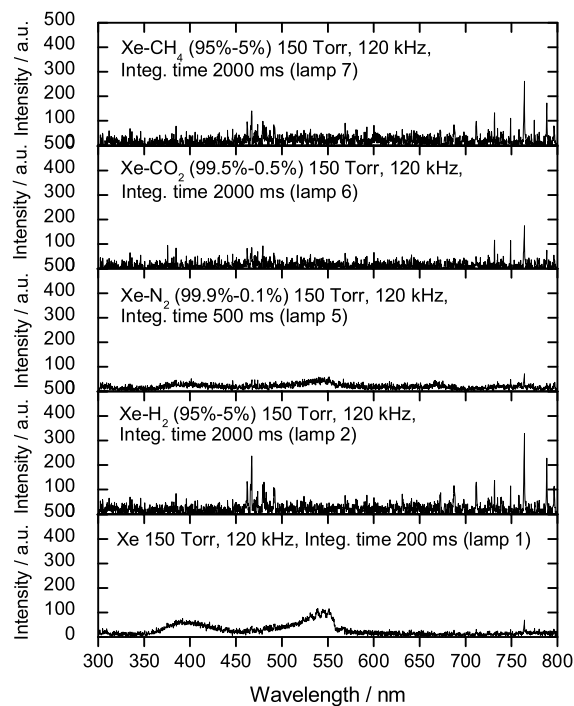


Figure 6. Emission spectra of the lamps with xenon reference lamp and impurities concentration lamps (lamps 2,5,6,7) at frequency 120 kHz.

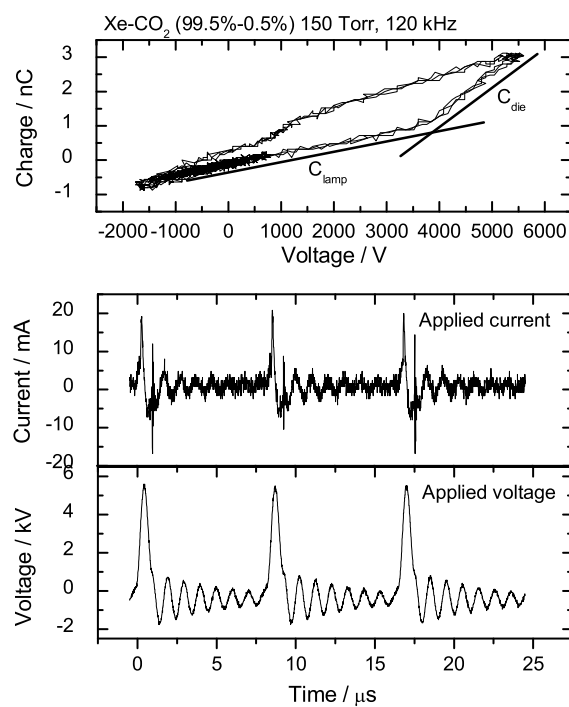


Figure 7. An example of the measured results of applied voltage, total current and displaced charge (Lissajous diagram).

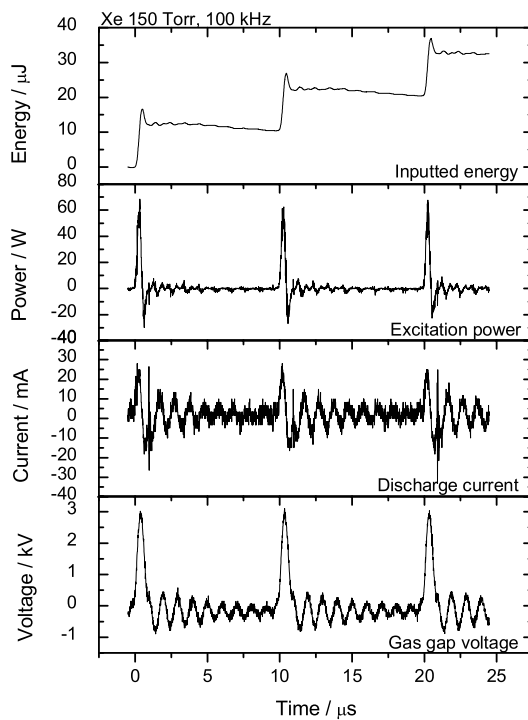


Figure 8. Electrical parameters of lamp 1 (Xe 150 Torr), xenon reference lamp.

Table 2. Peak values of voltage across the gap, discharge current, excitation power and inputted energy at frequency of 80, 100 and 120 kHz, for 25 μ s period.

Frequency / Lamp No.	Voltage (kV) (peaks average)	Current (mA) (peaks average)	Power (W) (peaks average)	Energy (μ J) (1st period)
80 kHz				
1	2.91	20.89	52.12	22.40
2	3.17	26.73	84.28	23.10
3	3.99	38.05	135.37	23.90
4	3.82	17.13	51.80	21.20
5	3.46	19.95	54.18	21.50
6	3.81	35.19	119.47	22.30
7	4.46	27.01	119.38	23.90
100 kHz				
1	3.02	25.90	66.05	26.90
2	2.50	24.43	61.94	22.30
3	3.66	34.76	111.11	23.30
4	4.11	19.29	65.88	27.60
5	3.76	20.51	54.50	19.50
6	3.12	34.84	89.86	20.90
7	4.03	22.89	90.77	24.80
120 kHz				
1	2.91	21.14	51.35	20.80
2	2.08	23.75	47.11	21.70
3	3.29	32.54	99.23	21.50
4	3.50	18.42	49.11	20.8
5	3.28	22.38	55.08	21.60
6	3.06	27.43	80.40	23.00
7	3.24	21.15	64.10	21.70